Identification of Silicate and Carbonaceous Presolar Grains
by SIMS in the Type 3 Enstatite Chondrite ALHA81189

Shingo Ebata\textsuperscript{a*}, Timothy J. Fagan\textsuperscript{b} and Hisayoshi Yurimoto\textsuperscript{a}
\textsuperscript{a}Department of Natural History Sciences, Hokkaido University, Sapporo 060-0810, Japan.
\textsuperscript{b}Department of Earth Sciences, School of Education, Waseda University, Tokyo, Japan.

Abstract

An isotope ratio imaging technique using the HokuDai isotope microscope system has been applied to \textit{in-situ} survey for presolar grains in the type-3 enstatite chondrite ALHA81189. Rastered and static ion beam were used for primary beam. Lateral resolution of the isotope image was achieved to be 0.4\mu m for static ion beam mode and to be 0.6 \mu m for rastered ion beam mode. As a result, the abundances of presolar grains are 150 to 200 \% larger under the static ion beam mode than under the rastered ion beam mode. Development of image processing introducing isotopography of $^{32}$S, $^{24}$Mg$^{16}$O and $^{56}$Fe$^{6}$succeeded to increase efficiency of presolar grain characterization. Using the static ion beam and introducing appropriate isotopography were very useful methods of \textit{in-situ} characterization of presolar grains in meteorites.

Keywords: Isotope microscope; SIMS; Imaging; Isotope ratio; Presolar grain; Meteorite

1. Introduction

Primitive meteorites contain presolar grains that predate the formation of our solar system. We know about stellar nucleosynthesis and the evolution from isotopic compositions of the presolar grains. Carbonaceous and oxide grains have been identified as a type of presolar grains and recently silicate grains have been found by O-isotope ion imaging with a NanoSIMS [1, 2], with isotope microscope (Cameca ims-1270 + SCAPS [3]) [e.g. 4].

Although about 200 presolar silicates were discovered, the chemical compositions of only 27 presolar silicate grains have been studied in meteorites [e.g. 2,4], IDPs [e.g. 1] and AMMs [e.g. 5], because it is difficult to specify presolar silicates embedded in abundant solar system silicates that are major constituents of meteorites. The spatial resolution and sensitivity of the conventional ion imaging technique have been difficult to identify sub-micron presolar silicate grains because of the small sizes (average sizes of identified grains \~300 nm). Among 27 presolar silicate grains, eight have compositions similar to olivine, eleven are pyroxene-like, and seven have GEMS (glass with embedded metal and sulfides)-like compositions. The sizes of presolar silicates seems to be between 100 and 1000 nm with most grains less than 300 nm.

Ebata et al. [6] have discovered presolar silicate and carbonaceous grains from three type 3 enstatite chondrites by \textit{in-situ} measurements. However, grain characterizations were limited to \~17\% of all presolar grains found. Developments of the effective characterization method are required.
Isotope microscope is a mass spectrometer that has capability of permil-precision isotope ratio imaging with micro-scale resolution under high mass-resolution [3]. This instrument is achieved by the combination of a stigmatic SIMS instrument and a two-dimensional ion detector SCAPS (stacked CMOS-type active pixel sensor). The stigmatic SIMS can project the isotope distribution of the sample surface to the SCAPS with keeping the positional information. The isotope image obtained using this method is called “isotopography” [4].

Here we report the developments of characterization for silicate and carbonaceous presolar grains in the type 3 enstatite chondrite ALHA81189 using isotopography.

2. Experimental

2.1. Presolar grain survey

We surveyed presolar grains by isotopography using a Hokudai isotope microscope system (Cameca ims 1270 and SCAPS). In this study we compared rastered and static primary ion irradiation for improvement of spatial resolution of secondary ion images.

Under the rastered ion beam condition, a 20-keV Cs\(^+\) primary ion beam of 5 µm in diameter was rastered over a 80X80 µm\(^2\) sample area to obtain homogeneous secondary ion-beam emission from an imaging area of 75X75 µm\(^2\). On the other hand, under the static beam condition, a 20-keV Cs\(^+\) primary ion beam with 75 µm in diameter was used to obtain secondary ion-beam emission. The shaped beam illumination mode was applied to obtain homogenous secondary ion-beam emission from the illumination area. A normal incident electron gun was used for charge compensation of the rastered area. The primary current was adjusted to ~0.5 nA for both mode. In order to obtain better lateral resolution of isotopography than the case of [4], a smaller contrast aperture (50 µm in diameter) was used in this study except for the case of C-isotopes. A larger contrast aperture (150 µm in diameter) was used for C-isotopography in order to minimize sample consumption by sputtering with an enough precision of isotope ratio through the sequence. Lateral resolutions of the isotopography using contrast aperture of the 50 µm and of the 150µm are 0.3-0.5 µm and ~1 µm, respectively. These analytical conditions keep the sputtering depth less than 100 nm for the sequence.

Under the rastered ion beam condition, we acquired the following isotopography for each analyzing field as a sequence of \(^{12}\)C\(^+\), \(^{13}\)C\(^+\), \(^{12}\)C\(^+\), \(^{27}\)Al, \(^{28}\)Si, \(^{16}\)O, \(^{18}\)O, \(^{16}\)O, \(^{17}\)O, and \(^{16}\)O. Total integration time for one field was ~1 hour.

Under the static beam condition, we acquired the following isotopography for each analyzing field as a sequence of \(^{12}\)C\(^+\), \(^{13}\)C\(^+\), \(^{12}\)C\(^+\), \(^{27}\)Al, \(^{28}\)Si, \(^{16}\)O, \(^{18}\)O, \(^{16}\)O, \(^{17}\)O, \(^{16}\)O, \(^{16}\)OH, \(^{32}\)S, \(^{24}\)Mg\(^{16}\)O and \(^{56}\)Fe. Total integration time for one field was ~1.5 hour because the number of the isotopography is larger in this mode.

The digital image processing, the selection criterion for distinguishing presolar grains and estimation of the analytical errors of the grains are the same as [4].

2.2. Presolar grain characterization

For positioning presolar grains in a back scattered electron image, we carefully compared among all elemental images by the isotope microscope and high resolution back scattered electron images by scanning electron microscope. After positioning the isotopically anomalous spot area on a back-scattered electron image, we applied quantitative microanalysis to determine the
chemical composition of the isotopically anomalous spot. The Mineralogical and petrographical characterization of isotopic anomalous grains and surrounding matrix has been conducted using a field emission type scanning electron microscope (JEOL JSM-7000F) equipped with energy dispersive X-ray spectrometer (Oxford INCA Energy).

Elemental maps were collected with 5 and 15kV of accelerating voltage for determining pinpoint the exact location of this grain. The 5kV irradiation condition is more suitable for collecting light elements, especially carbon.

Quantitative microanalyses were performed with 5 and 15 kV electron probe with the beam current of 3.0 and 0.9 nA, respectively. The estimated spatial resolution is 0.3 and 1 µm for 5 and 15 kV electron probe condition, respectively.

3. Results and discussion

3.1. Abundances and Lateral resolution

The lateral resolution under rastered ion beam mode was ~0.6µm, whereas lateral resolution under static ion beam mode, was ~0.4µm (Fig. 1). These lateral resolutions were improved more the five times comparing with previous work [6]. The lateral resolution is more improved under the static ion beam mode. This indicates that the static ion radiation introduces stable electrostatic condition of sample surface comparing with the rastered ion irradiation probably because the secondary ion images are sensitive to the variation of the electrostatic field on the sample surface.

Volume abundances of presolar silicate and carbonaceous grains in matrix were obtained to be ~14 and ~9 ppm, respectively, assuming the mean grain size to be 0.3 µm in diameter, respectively, under the rastered ion beam mode, whereas were obtained to be ~22 and ~17 ppm, respectively, under the static ion beam mode.

The abundances of presolar silicate and carbonaceous grains under the static ion beam mode increases of ~60 and ~90% larger than those under the rastered ion beam mode, respectively [7].

Silicate/carbonaceous-grain ratio under static ion beam mode (~1.3±0.3) is almost the same as those under rastered ion beam

![Fig. 1. Lateral resolution of isotopography. (a) Lateral resolution was ~0.6µm using rastered ion beam. (b) Lateral resolution was ~0.4µm using static ion beam.](image)

![Fig. 2. The abundances of presolar silicate and carbonaceous grains in the case of using rastered and static ion beam. Error bars are 2σ. Silicate/C-grain ratios are calculated to be ~1.6 for rastered ion beam mode and ~1.3 for static ion beam mode.](image)
mode (~1.6±0.4) (Fig.2). This indicates that the increase of presolar grain abundances under the static ion beam mode is not due to the heterogeneous distribution between the two types of presolar grain in the meteorite. The abundance increase is consistent to the improvement of spatial resolution of isotopography.

3.2. Characterization of presolar grains

Characterization efficiency for presolar grains has been limited to ~11% for silicate grains and 0% for carbonaceous grains [6]. New isotopographies of $^{32}$S, $^{24}$Mg$^{16}$O$^{-}$ and $^{56}$Fe$^{-}$ were very useful of grain characterization (Fig. 3). The elements of Mg, S, and Fe were major phase forming elements in the meteorites and are useful to position matching between isotopography and the corresponding images of electron microscope. Therefore it makes easier to determine the presolar grain position. Especially, Mg isotope image is very useful because we can distinguish between olivine (indicated by white arrow grains in Fig.3a) and pyroxene (gray grains in Fig.3a, which are not indicated by arrows).

Six presolar silicate grains were determined the chemical compositions [8]. Three presolar carbonaceous grains were determined the chemical compositions [8]. Grain characterization efficiency increases to 60% for silicate presolar grains and ~43% for carbonaceous presolar grains.

Introduction of isotopography of $^{32}$S, $^{24}$Mg$^{16}$O$^{-}$ and $^{56}$Fe$^{-}$ was succeeded to develop the presolar grain characterization in the meteorite.

4. Conclusions

In-situ presolar grains survey was performed with isotope microscope. Grain characterization efficiency increased to 60% for silicate and ~43% for carbonaceous using static ion beam and $^{32}$S, $^{24}$Mg$^{16}$O$^{-}$ and $^{56}$Fe$^{-}$ isotopography. These results indicate that it is very useful for characterization of presolar grains to use static ion beam for improving lateral resolution and $^{32}$S, $^{24}$Mg$^{16}$O$^{-}$ and $^{56}$Fe$^{-}$ isotopography as major position markers.

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References